



EMC Test Report

Product Name: LTE Wireless Gateway

Model Number: B890-66s,H350L

Report No: SYBH(Z-EMC)001042014-2

FCC ID: QISB890

Reliability Laboratory of Huawei Technologies Co., Ltd.

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2. The laboratory has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
3. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
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Applicant: Huawei Technologies Co., Ltd.
Address: Administration Building, Headquarters of Huawei
Technologies Co., Ltd., Bantian, Longgang District,
Shenzhen, 518129, P.R.C

Date of Receipt Test Item: Apr.07, 2014

Start Date of Test: Apr.07, 2014

End Date of Test: Apr.11, 2014

Test Result: Pass

**Approved By
(Lab Manager)**

2014-04-15
Date

Liu Chunlin
Name

Signature

Operator

2014-04-15
Date

Yue Meng
Name

Signature



Modification Record

No.	Last Report No.	Modification Description
1	NA	First report

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1 General Information

1.1 EUT Description

EUT Description	
Product Name	LTE Wireless Gateway
Model Number	B890-66s,H350L
Serials Number	Z6V01A9431100040
Working Voltage	12Vdc
TX Frequency	WCDMA Band II: 1850MHz To 1910MHz WCDMA Band V: 824MHz To 849MHz LTE BAND 2:1850MHz To 1910MHz LTE BAND 4:1710MHz To 1755MHz LTE BAND 5:824MHz To 849MHz LTE BAND 17:704MHz To 716MHz WIFI: 2400MHz To 2483.5MHz
RX Frequency	WCDMA Band II: 1930MHz To 1990MHz WCDMA Band V: 869MHz To 894MHz LTE BAND 2:1930MHz To 1990MHz LTE BAND 4:2110MHz To 2155MHz LTE BAND 5:869MHz To 894MHz LTE BAND 17:734MHz To 746MHz WIFI: 2400MHz To 2483.5MHz
HW Version	WL1B890I
SW Version	V100R001
EUT Accessory	
Adapter	BRAND: HUAWEI Model:HW-120200U6W Input voltage: 100V-240V~50/60Hz, 0.8A Output voltage: +12V $\overline{\text{---}}$ 2A SN: HWHKABC72600031 SN: HWXQAADC1207399

Remark: The information of the EUT is declared by the manufacturer. Please refer to the specifications or user manual for details.



1.2 Differences Description

The difference between B890-66s, H350L and B890-66 is only in software, the others are the same. H350L/B890-66s disabled WCDMA Band4, LTE Band 7/12/13 by software while B890-66 enabled.

With the consideration of identities and differences listed above, all the test result refers to **No. SYBH(Z-EMC)109082012-2** of B890-66 test report.

1.3 Test Site Information

Test Site 1:	RELIABILITY LABORATORY OF HUAWEI TECHNOLOGIES CO., LTD.
Test Site Location:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.4 Applied Standards

APPLIED STANDARD

47 CFR FCC Part 15:2013, Subpart B

2 Summary of Results

Summary of Results				
Test Items	Test Mode	Performance Class & Required Performance Criteria	Result	Site
<u>Radiated Emissions</u> Enclosure Port	Mode1 Mode2	CLASS B	Pass	Site1
<u>Conducted Emissions</u> <input checked="" type="checkbox"/> DC Power Port <input checked="" type="checkbox"/> AC Power Port <input type="checkbox"/> Telecommunication Ports	Mode1 Mode2	CLASS B	Pass	Site1
Note: 1, Measurement taken is within the uncertainty of test system. 2, <input checked="" type="checkbox"/> The item has been tested; <input type="checkbox"/> The item has not been tested.				

During the measurement, the environmental conditions complied with the range listed as below.

Item	Required
Ambient temperature	15°C ~ 35°C
Relative humidity	25% ~ 75%
Atmospheric pressure	86kPa ~ 106kPa

3 System Configuration during EMC Test

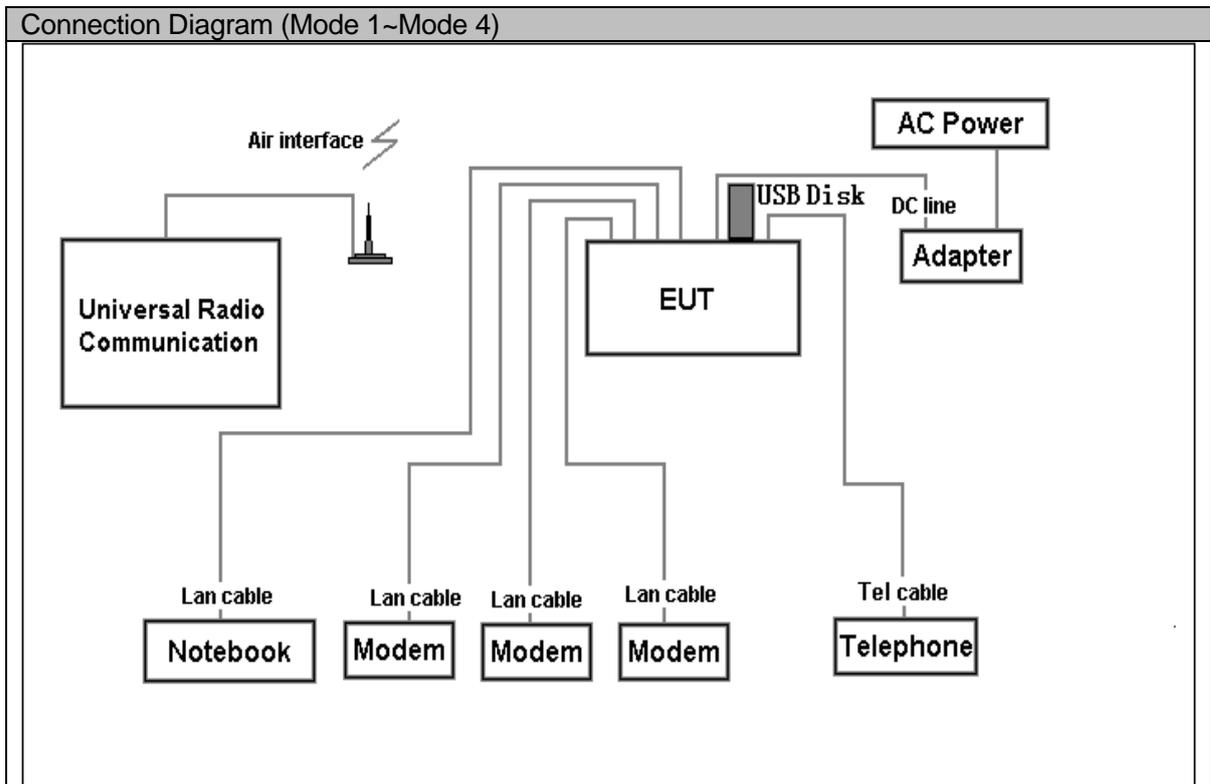
3.1 Test Mode

The EUT was configured, installed, arranged and operated in a manner consistent with typical application. The following mode(s) were applied during the compliance test.

Test Mode	
Mode 1:	Adapter + USB Disk + Traffic + LAN + Telephone
Mode 2:	Adapter + USB Disk + Idle + LAN + Telephone

Remark: If there is more than one adapter, each one should be applied throughout the compliance test respectively, however, only the worst case will be recorded in this report.

3.2 Test System Configuration



3.3 Cables Used during Test

Cable	Quantity	Length	Type of Cable
DC Power Cable	1	<3m	unshielded
LAN Cable	4	<3m	unshielded
Telephone Cable	1	<3m	unshielded
Antenna Cable	1	<3m	shielded

3.4 Associated Equipment Used during Test

Name	Model	Manufacturer	S/N	Calibrated Deadline	Cal interval (month)
Radio Communication Tester	CMU200	R&S	117057	2014-10-28	12
Wideband Radio Communication Tester	CMW500	R&S	115624	2014-09-01	12
Notebook	X200	ThinkPad	31090403588	/	/
USB Disk	Data Traveler	Kingston	N/A	/	/
Modem	MT800b	HUAWEI	21500802378068000074	/	/
Modem	MT800b	HUAWEI	21500802378068000075	/	/
Modem	MT800b	HUAWEI	2199040XWC7S86146674	/	/
Telephone	HCD8166 TSD	HUAWEI	21990482848X65001901	/	/

4 Electromagnetic Interference (EMI)

4.1 Radiated Disturbance 30MHz to 18GHz

4.1.1 Test Procedure

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4dB according to the standards: ANSI C63.4-2009. The test distance was 3m. The set-up and test methods were according to ANSI C63.4-2009.

A preliminary scan and a final scan of the emissions were made from 30 MHz to 18 GHz by using test script of software; The emissions were measured using Quasi-Peak Detector (30MHz~1GHz) and AV/PK detector (above 1GHz). The maximal emission value was acquired by adjusting the antenna height, polarisation and turntable azimuth in accordance with the software setup. Normally, the height range of antenna was 1m to 4m. The azimuth range of turntable was 0° to 360°. The receiving antenna has two polarizations V and H.

Measurement bandwidth (RBW) for 30MHz to 1000 MHz: 120 kHz;

Measurement bandwidth (RBW) for 1000MHz to 18000 MHz: 1MHz;

EUT was configured in idle mode and the test performed at worst emission state.

4.1.2 Test setup

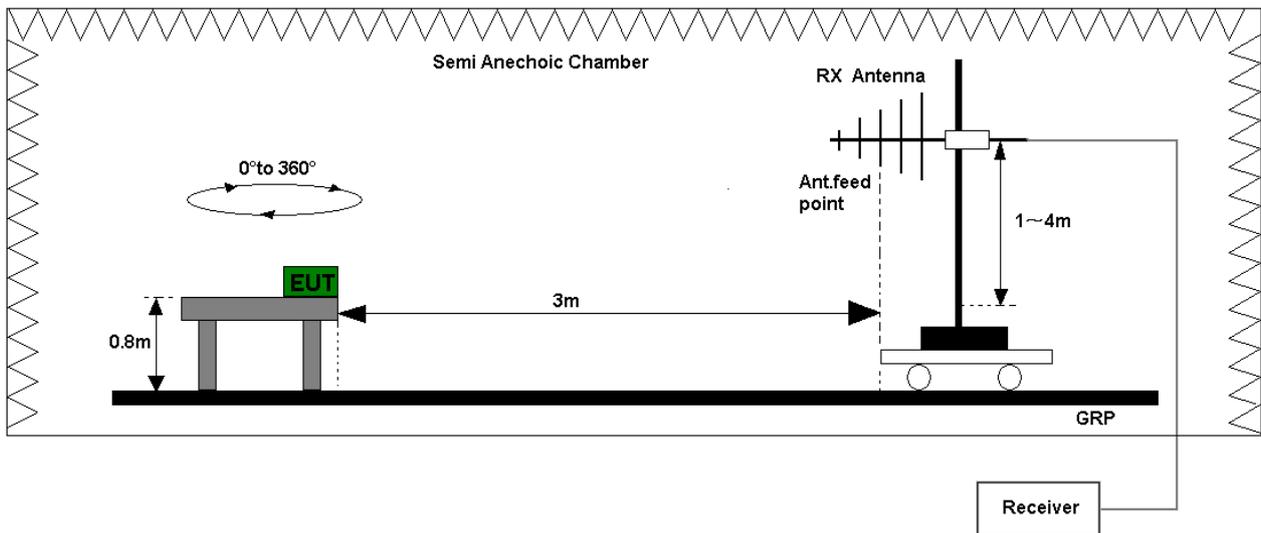


Figure 1. Test set-up of radiated disturbance(30MHz-1GHz)

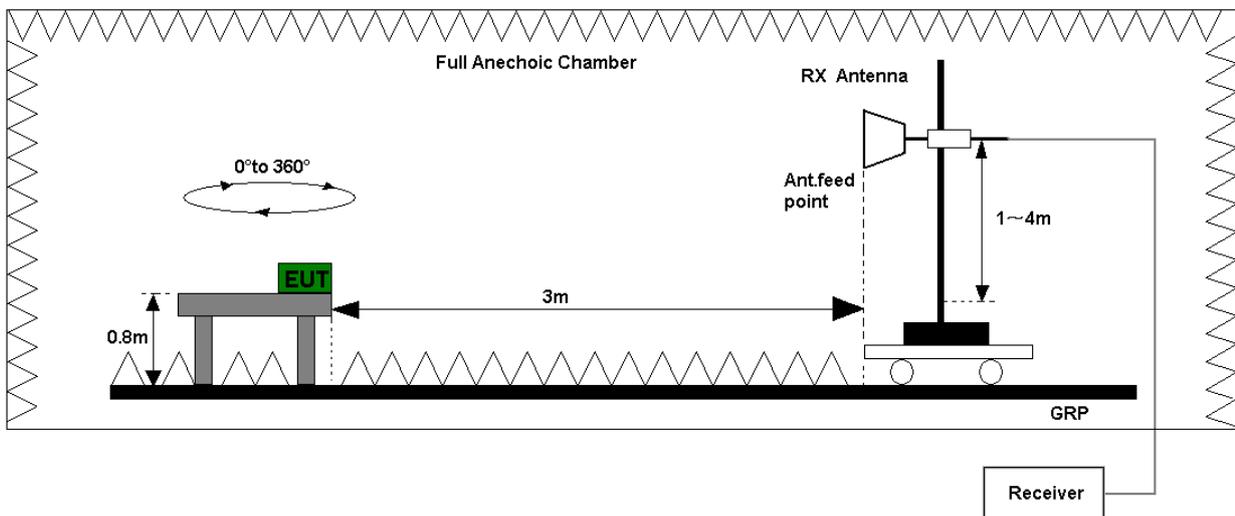


Figure 2. Test set-up of radiated disturbance(above 1GHz)

4.1.3 Test Results

The EUT has met the requirements for Radiated Emission of enclosure port.
Refer to the section 7.1 of this report for test data.

Test Limits (Class B)				
Frequency of Emission (MHz)	Radiated Limit			
	Unit(μ V/m)		Unit(dB μ V/m)	
30-88	100		40	
88-216	150		43.5	
216-960	200		46	
Above 960	500		54	
Above 1000	AV	PK	AV	PK
	500	5000	54	74

4.2 Conducted Disturbance 0.15 MHz to 30MHz

4.2.1 Test Procedure

The Table-top EUT was placed upon a non-metallic table 0.8 m above the horizontal metal reference ground plane. EUT was connected to LISN and LISN was connected to reference Ground Plane. EUT was 80cm away from LISN. The set-up and test methods were according to ANSI C63.4-2009. Conducted Disturbance at AC Port measurements were undertaken on the L and N Lines. The emissions were measured using a Quasi-Peak Detector and Average Detector. EUT was communicated with the simulator through Air interface, the simulator controls the EUT to transmitter the maximum power which defined in specification of product. The EUT operated on the typical channel.

Measurement bandwidth (RBW) for 150 kHz to 30 MHz: 9 kHz;

The EUT was setup in the shielded chamber and operated under nominal conditions.

4.2.2 Test Setup

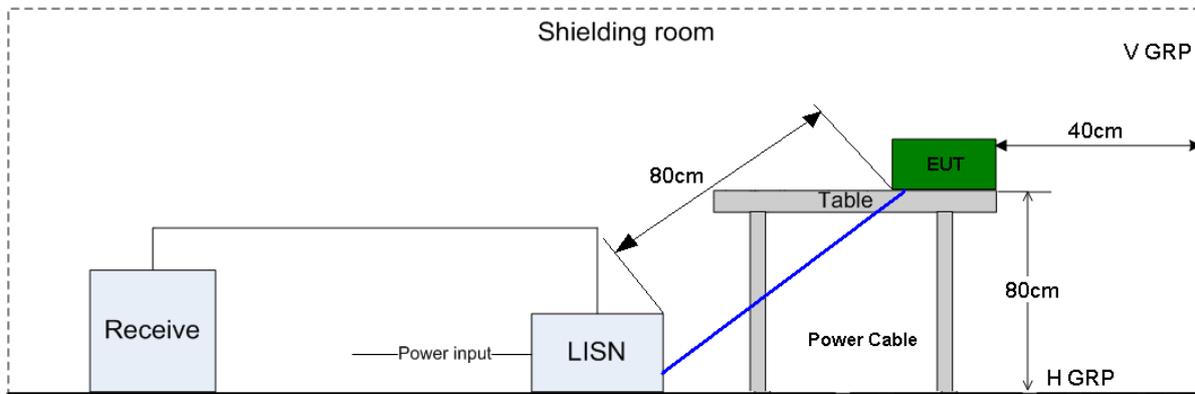


Figure 3. Test Set-up of conducted disturbance

4.2.3 Test Results

The EUT has met requirements for Conducted disturbance of power lines.

Refer to the section 7.2 of this report for test data.

Test Limit of AC Power Port		
Frequency range	150kHz ~ 30MHz	
Frequency	Voltage limits	
	QP (dB μ V)	AV (dB μ V)
0.15MHz~0.5MHz	66-56	56-46
0.5MHz-5MHz	56	46
5MHz~30MHz	60	50

5 Main Test Instruments

Main Test Equipments						
Test item	Test Instrument	Model	S/N	Manufacturer	Calibrated Deadline	Cal interval (month)
RE	EMI Test receiver	ESU26	100150	R&S	May.14, 2014	12
	Broadband Antenna	VULB 9163	9163-520	SCHWARZBECK	Dec.20, 2015	24
	Double Ridged Horn Antenna	HF906	100683	R&S	Feb.01, 2015	24
CE	EMI Test receiver	ESCI	101163	R&S	Dec.23, 2014	12
	Line Impedance Stabilization Network	ENV216	100382	R&S	Dec.23, 2014	12
	Line Impedance Stabilization Network	ENV4200	100134	R&S	Dec.23, 2014	12
Software Information						
Test Item	Software Name		Manufacturer		Version	
RE	ES-K1		R&S		V1.7.1	
CE	EMC32		R&S		V8.40.0	

6 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty		
Items	Extended Uncertainty	
RE(30MHz-1GHz)	Field strength (dB μ V/m)	U=4.1dB; k=2
RE(1GHz-18GHz)	Field strength (dB μ V/m)	U=5.0dB; k=2
CE	Disturbance Voltage (dB μ V)	U=2.6dB; k=2

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